

COMPLIANT

### STP6NK90Z-VB Datasheet

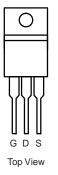
## N-Channel 900V (D-S) Super Junction Power MOSFET

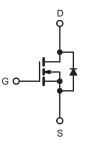
PRODUCT SUMMARY					
V <sub>DS</sub> (V)	900				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V 1.3				
Q <sub>g</sub> (Max.) (nC)	200				
Q <sub>gs</sub> (nC)	24				
Q <sub>gd</sub> (nC)	110				
Configuration	Single				

#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub>	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	900	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20	v	
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>	5		
Continuous Drain Current		T <sub>C</sub> = 100 °C		3.9	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	21		
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	770	mJ	
Repetitive Avalanche Current <sup>a</sup>			I <sub>AR</sub>	7.8	A	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	19	mJ	
Maximum Power Dissipation T <sub>C</sub> = 25 °C		PD	190	W		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature) for 10 s		-	300 <sup>d</sup>			
Mounting Torque	6-32 or M3 screw			10	lbf ∙ in	
			Ē	1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 23 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 7.8 \text{ A}$  (see fig. 12). c.  $I_{SD} \leq 7.8 \text{ A}$ , dI/dt  $\leq 140 \text{ A/}\mu\text{s}$ ,  $V_{DD} \leq 600 \text{ V}$ ,  $T_J \leq 150 \text{ °C}$ .

d. 1.6 mm from case.

\* Pb containing terminations are not RoHS compliant, exemptions may apply

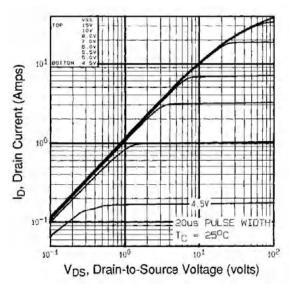
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THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP.		MAX.		UNIT			
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		40					
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24		-		°C/W			
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 0.65				]			
<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, u	nless otherwi	se noted)							
PARAMETER	SYMBOL	1	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT	
Static						I	I	<b></b>	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 2	250 µA	900	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.98	-	V/°C	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> = 1	250 µA	2.0	-	4.0	V	
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 20$	V	-	-	± 100	nA	
		V <sub>DS</sub> =	= 800 V, V <sub>G</sub>	<sub>S</sub> = 0 V	-	-	100	μA	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 640 \	/, V <sub>GS</sub> = 0 \	/, T <sub>J</sub> = 125 °C	-	-	500		
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub>	= 3.7 A <sup>b</sup>	-	1.3	-	Ω	
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =	= 100 V, I <sub>D</sub> =	= 3.7 A <sup>b</sup>	5.6	-	-	S	
Dynamic									
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V		-	3100	-		
Output Capacitance	C <sub>oss</sub>	1	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5		-	800	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1			-	490	-		
Total Gate Charge	Qg				-	-	200		
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$		A, V <sub>DS</sub> = 400 V, g. 6 and 13 <sup>b</sup>	-	-	24	nC	
Gate-Drain Charge	Q <sub>gd</sub>	1	300 1	9. 0 414 10	-	-	110		
Turn-On Delay Time	t <sub>d(on)</sub>				-	19	-	ns	
Rise Time	tr		= 400 V, I <sub>D</sub> =		-	38	-		
Turn-Off Delay Time	t <sub>d(off)</sub>	R <sub>g</sub> =	= 6.2 Ω, R <sub>D</sub> =	= 52 Ω <sub>b</sub>	-	120	-		
Fall Time	t <sub>f</sub>	1	see fig. 10 <sup>b</sup>		-	39	-	1	
Internal Drain Inductance	L <sub>D</sub>	Between lead 6 mm (0.25") f	from		-	5.0	-		
Internal Source Inductance	L <sub>S</sub>	package and center of die contact		-	13	-	nH		
Drain-Source Body Diode Characteristic	s	•				•		•	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	A		
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	21			
Body Diode Voltage	V <sub>SD</sub>	$T_J$ = 25 °C, $I_S$ = 3.8 A, $V_{GS}$ = 0 V <sup>b</sup>		-	-	1.8	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.8 A, dl/dt = 100 A/μs <sup>b</sup>		-	650	980	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.8	5.7	μC		
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn		-on is dor	ninated h	$_{\rm by L_{S}}$ and	Ln)		

#### Notes

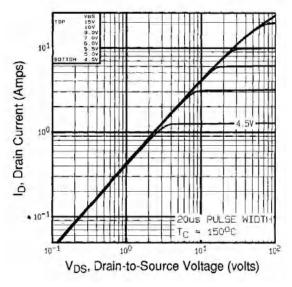
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.





#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)







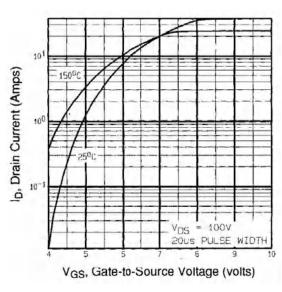
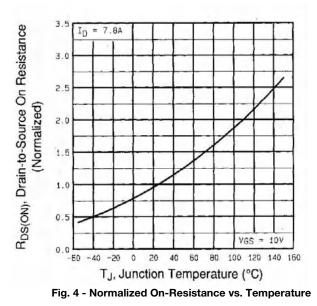


Fig. 3 - Typical Transfer Characteristics





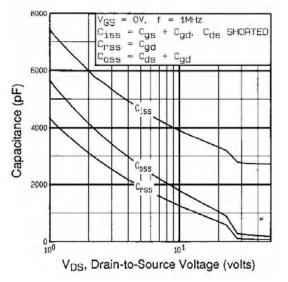


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

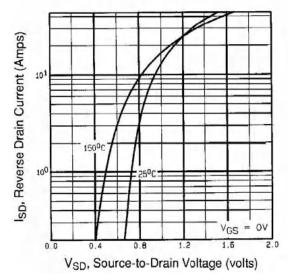


Fig. 7 - Typical Source-Drain Diode Forward Voltage

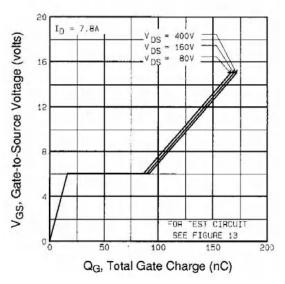
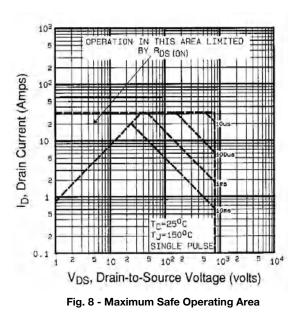


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





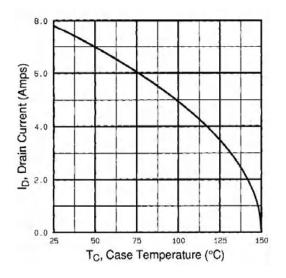


Fig. 9 - Maximum Drain Current vs. Case Temperature

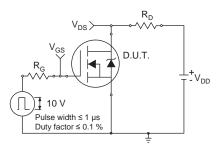


Fig. 10a - Switching Time Test Circuit

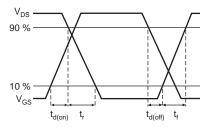


Fig. 10b - Switching Time Waveforms

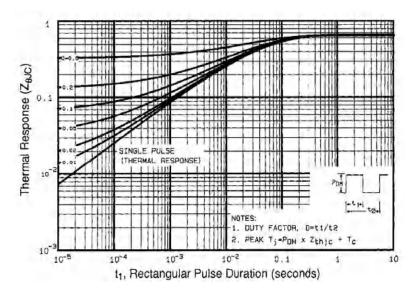


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



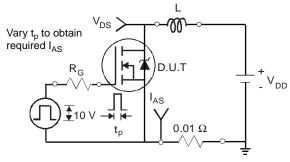


Fig. 12a - Unclamped Inductive Test Circuit

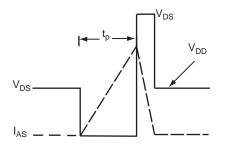


Fig. 12b - Unclamped Inductive Waveforms

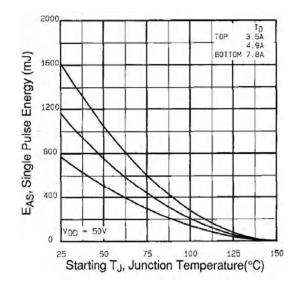


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

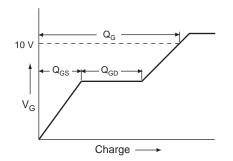


Fig. 13a - Basic Gate Charge Waveform

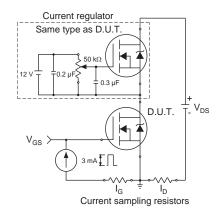
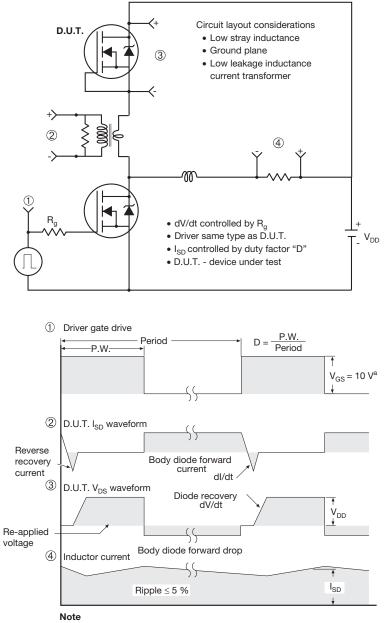


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

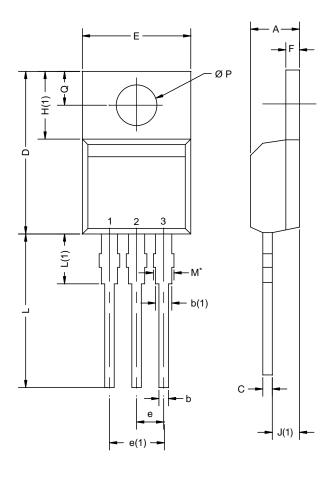


a.  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel



# **TO-220AB**



	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12- DWG: 547	0208-Rev. N, 1	08-Oct-12			

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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